

<b>Notice of References Cited</b>	Application/Control No. 09/811,684	Applicant(s)/Patent Under Reexamination DEMBO ET AL.	
	Examiner Harish T Dass	Art Unit 3628	Page 1 of 1

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	C	US-5,303,328	04-1994	Masui et al.	706/25
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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